

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/674,924	<b>Applicant(s)/Patent under Reexamination</b> MURI, DAVID L.
	<b>Examiner</b> Gregory B. Sefcheck	<b>Art Unit</b> 2662

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner